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SCHOOL ON SYNCHROTRON RADIATION AND APPLICATIONS In memory of J.C. Fuggle & L. Fonda

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Optical components for hard x-ray beamlines

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School on Synchrotron Radiation 27 - 28 April 2004

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Optical components for hard x-ray beamline

High brilliance and small electron beam emittance mean X-ray beams of high quality



Mirrors 1: total reflection

 $\begin{array}{ll} \mbox{For x-rays the refractive index is} & n = 1 - \delta \\ \mbox{with } 0 < \delta << 1, & \mbox{therefore is} & 0 < n < 1 \\ \end{array}$

If we consider ϑ as the angle that the incoming radiation does with the mirror surface (*grazing angle*), the photons will be totally reflected if $\vartheta < \vartheta_c$



 $\vartheta < \vartheta_c$





$$\vartheta = \vartheta_0$$











Mirrors 2: focussing

In the ideal mirror device all rays from one particular **point** are reflected and focused into another **point** according to 1/q + 1/p = 1/f

















the optical prism is used to separate the components of the white visible light

sampling the out coming light with a slit it is possible to select a part of the spectrum with a spectral purity which depends on the distance and the slits aperture.





the Bragg's law

Radiation of wavelength λ is reflected by the lattice plane. The outgoing waves interfere. The interference is constructive only if the difference of optical path is a multiple of λ :







from the Bragg law



therefore



and the Bragg angle is 90°



important properties for the x-ray monochromators

ENERGY RESOLUTION



 $\Delta \vartheta$ has two contribution :

 $\Delta \vartheta_{\text{beam}}$ - beam angular spread (optics) ω_{crystal} - intrinsic reflection width of the monochromator



Case of $\Delta \vartheta_{beam} >> \omega_{crystal}$

white beam with divergence in the plane of scattering









Second crystal in <u>non dispersive</u> configuration







Second crystal in <u>dispersive</u> configuration





Rays incident at a lower angle than the central ray on the first crystal are incident at a higher angle on the second crystal.

energy resolution fintensity of the reflection





two models for the x-ray diffraction in single crystals

kinematical model					
	apply this model for: - thin perfect crystals - distorted or mosaic crystals				
a t Q	according with Darwin model (1922) the mosaic crystal is defined by two general conditions: - crystallites have to be				

misoriented more than the Darwin with of the perfect crystal (loss of the phase condition)

 their dimensions have to be smaller than the extintion length of the considered radiation (no second interaction)



dynamical model

apply this model for:

- thick and perfect crystal

- a) we can't longer consider single interaction. (extinction length)
- b) we can't neglect, as well as in the kinematical model, the effect of the radiation absorption



Laboratory

the **b** parameter defined as :



$\pmb{\alpha}$ is the angle between the Bragg plane and the crystal surface

T. Matsushita and H. Hashizume X-Ray Monochromators Handbook on Synchrotron Radiation, Vol. 1



Fig. 3. Geometry of X-ray reflection by a perfect single crystal. θ_0 : incidence angle; θ_h : reflection angle. For a non-zero asymmetry angle α ($0 < |\alpha| < \theta_B$), the angular width ω_0 for acceptance is not equal to the angular width ω_h for emergence. The figure is drawn for b < 1.0, where $\omega_0 > \omega_s > \omega_h$. Note also the change of beam cross sections, S_0 and S_h .



the angular acceptance as function of the intrinsic width and the **b** parameter:





Fig. 3. Geometry of X-ray reflection by a perfect single crystal. θ_0 : incidence angle; θ_h : reflection angle. For a non-zero asymmetry angle α ($0 < |\alpha| < \theta_B$), the angular width ω_0 for acceptance is not equal to the angular width ω_h for emergence. The figure is drawn for b < 1.0, where $\omega_0 > \omega_s > \omega_h$. Note also the change of beam cross sections, S_0 and S_h .

Bragg reflection width in case of asymmetric cut crystal is defined by:





the angular acceptance as function of the Bragg reflection width

also for the beams sections











Fig. 4. Perfect-crystal reflection curves for the (111) reflection of silicon at 1.6 Å. $R(\theta_0)$ shows the reflectivity for the ideal plane wave as a function of the incidence angle θ_0 , while $R(\theta_h)$ represents the intensity reflected at a reflection angle θ_h for a plane wave incident at θ_0 , θ_0 and θ_h being related by $(\theta_h - \theta_B) = b(\theta_0 - \theta_B)$. The solid curves are calculated for an asymmetric case of b = 0.4, while the broken curves for the symmetric case (b = 1.0) where $R(\theta_0) \equiv R(\theta_h)$.

T. Matsushita and H. Hashizume X-Ray Monochromators Handbook on Synchrotron Radiation, Vol. 1, edited by E.E. Kock North-Holland Publishing Company, 1983



Crystal	hkl	ω _s (second or arc)	Δ <i>E/E</i> (×10 ⁵)	I (×10 ⁶)
Silicon	111	7.395	14.1	39.9
	220	5.459	6.04	29.7
	311	3.192	2.90	16.5
	400	3.603	2.53	19.3
	331	2.336	1.44	11.8
č. 19 10 10	422	2.925	1.47	15.5
	333 (511)	1.989	0.88	9.9
in all an we	440	2.675	0.96	14.0
	531	1.907	0.60	9.3
Germanium	111	16.338	32.64	85.9
¢	220	12.449	14.46	67.4
	311	7.230	6.92	37.1
20	400	7.951	5.94	42.3
	331	5.076	3.34	25.4
	422	6.178	3.34	32.4
	333 (511)	4.127	2.00	20.2
	440	5.339	2.14	27.5
•	531	3.719	1.33	17.7
α-quartz	100	3.798	10.00	18.8
	101	7.453	15.26	40.9
	110	2.512	3.69	12.2
	102	2.488	3.36	12.9
	200	2.252	2.81	11.5
	112	2.927	3.03	15.5
	202	2.072	1.93	10.6
	212	2.042	1.47	10.7
	203	2.430	1.74	12.9
	301	2.368	1.69	12.6

Table 2 deb

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Fig. 33. An off-set harmonics-rejection monochromator. (a) Geometry of the monochromator. (b) The principle of harmonics rejection. Perfect-crystal reflection curves for the fundamental (n = 1) and the harmonics (n = 2, 3) are approximated by rectangular boxes. ε : off-set or misalignment angle. The shaded area represents delivered X-rays (Hart and Rodrigues 1978).

T. Matsushita and H. Hashizume X-Ray Monochromators Handbook on Synchrotron Radiation, Vol. 1







Fig. 34. A monolithic harmonics-rejection monochromator. (a) Crystals I and II of unequal asymmetry factors are built as two outstanding parts of a perfect single crystal. (b) The principle of harmonics rejection. Perfect-crystal reflection curves for the fundamental (n = 1) and the harmonics (n = 2, 3) are approximated by rectangular boxes. The broken curves show the real reflection curves for the fundamental. The shaded area represents delivered X-rays.



T. Matsushita and H. Hashizume X-Ray Monochromators Handbook on Synchrotron Radiation, Vol. 1





T. Matsushita and H. Hashizume **X-Ray Monochromators** *Handbook on Synchrotron Radiation, Vol. 1*

Note as the refractive effect on the first crystal has been totally compensated by the second one



Double crystal monochromator



Double crystal monochromator

Diffraction 1 57 poles wiggler source at ELETTRA 400mA, 1.6T and 2GeV total power: 8 kW

The double crystal monochromator at the **diffraction1** beamline

Diffraction 1: first optical element in the beam Si(111) internally water cooled

total power absorbed 0.5 kW*

* 1.5 x 0.28 mrad²

Conceptual design of an internally water cooled crystal

The two Si components before the Si-Si brazing

channels:

Sincrotrone Trieste S.c.p.A. Hard-X Ray Optics Laboratory thickness: 300µm depth: 2mm

3D picture of the double ϑ-2ϑ equipment

The double ϑ -2 ϑ test station at the Hard X-ray Laboratory

DISTRIBUZIONE DELL'AMPIEZZA DELLE ROCKING-CURVE VALUTATE MEDIANTE DIFFRAZIONE SUI PIANI SI-111

	14.1	
	13.6	
	13.1	
	12.6	
	12.1	
	11.6	
	11.1	
	10.7	
	10.2	
	9.7	
1		

Valori espressi in secondi di grado

Topography of the internal cooled Si-crystal with channels perpendicular to the scattering plane

Same topography but with channels in the same direction of the scattering plane

surface of a Si(111) crystal with a evident stressed structure induced by a back-side machining and not removed by chemical hatching

The inclined double crystal monochromator setup to reduce the power density

Si(111) inclined channel-cut crystal monochromator designed for the ALOISA beamline.

energy range: 2.8 to 8 KeV beam dimension: 3x3 mm source: wiggler-ondulator

E. Busetto et al.: "*The High Energy Monochromator for the ALOISA Beamline*". Rev. Sci. Instrum. **66** (2), February 1995

A new prototype of monochromator under test with x-rays

- Single counters :
- These systems allow to collect all the electrons produced by the absorption of an x-ray.
- The mean number of electrons produced during the absorption process is proportional to energy of the single x-ray.

Scintillatori

I rivelatori ascintillazione sono il risultato dell'accoppiamento di un cristallo isolante drogato e di un convertitore-moltiplicatore optoelettronico, il fototubo

Integratori

- Sono sistemi di rivelazione "integrata" nel tempo dove si perde la correlazione diretta fra elettroni prodotti ed energia del fotone incidente.
- L'intensità del segnale locale deve essere proporzionale al numero di fotoni assorbiti nella stessa zona.

La pellicola radiografica

è stato ed è tuttora uno tra i più usati rivelatori ad integrazione sfrutta la sensibilità alle radiazioni elettromagnetiche degli alogenuri di argento in particolare dell' AgBr. La reazione fotochimica produce ioni di Ag⁺ con una densità proporzionale alla quantità di radiazione assorbita. Le sostanze fortemente riducenti utilizzate negli sviluppi trasformano Ag⁺, localmente prodotto, in Ag metallico dalla tipica colorazione nera.

Curva caratteristica della dendità contro il tempo di esposizione

Integratori bidimensionali digitali

Spaccato di un rivelatore CCD commerciale per raggi X

DETE

Linearità, range dinamico ed efficienza a confronto

Fisica dell'Image Plate.....un rivelatore analogico a lettura digitale

I rivelatori a gas : principio di funzionamento

Wiggler insertion devices at ELETTRA

Permanent magnet Wiggler W14.0 XRD1 source:

- * B_0 = 1.6 Tesla
- * Period length = 140 mm *
 - No. of poles = 59
- Total length = 4500 mm *
- * κ_y
- * Ecm

- = 19.6
 - = 4.2 Kev (2GeV) / 6.0KeV (2.4GeV)

Multipole Superconducting Wiggler XRD2 source:

- = 3.5 Tesla * B_0 Period length = 64 mm* * No. of poles = 49 Total length * = 1568 mm
- = 20.9
- = 9.2 KeV(2GeV) / 13.2KeV(2.4GeV)

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*

*

K_v

Ecm

Premirror:

Final shape: Tangential radius: Grazing angle: Source distance: **cylindrical vertical collimator** 13.5 Km 0.18° (200 μrad vertical) 21139 mm

1400 x 45 mm²

Active optical surface:

Premirror:

Final shape: Tangential radius: Grazing angle: Source distance: **cylindrical vertical collimator** 13.5 Km 0.18° (200 μrad vertical) 21139 mm

1400 x 45 mm²

Active optical surface:

Focalising mirror:

Final shape	toroidal		
Tangential radius:	6.0 Km	(0.18°)	
Saggittal radius:	49.9 mm	(0.18°)	
Grazing angle:	0.18°		
Source distance:	26932 mm		
Active optical surface:	1400 x 55 mm²		
Focal distance:	11000 mm with 0.18°		
Demagnification:	1.9:1 vertical plane		
	2.4:1 horizontal plane		

Premirror:

Final shape: Tangential radius: Grazing angle: Source distance: **cylindrical vertical collimator** 13.5 Km 0.18° (200 μrad vertical) 21139 mm

1400 x 45 mm²

Active optical surface:

Focalising mirror:

Final shape	toroidal		
Tangential radius:	6.0 Km	(0.18°)	
Saggittal radius:	49.9 mm	(0.18°)	
Grazing angle:	0.18°		
Source distance:	26932 mm		
Active optical surface:	1400 x 55 m	m²	
Focal distance:	11000 mm with 0.18°		
Demagnification:	1.9:1 vertical plane		
	2.4:1 horizontal plane		

Horizontal acceptance: Vertical acceptance:

Sincrotrone Trieste S.c.p.A. Hard-X Ray Optics Laboratory 1mrad max 200μrad

Laboratory

wavelength cutoff [Å] energy cutoff [keV] grazing angle[deg]

SCW 2GeV, 320 mA, 1 mradH x 0.2mradV

Incoming power[watt]absorbed power[watt]reflected power[watt]

	584	664	748
0.5 24.8KeV 0.1505ū	180 404	185 479	190 557
0.55 22.5KeV 0.167ū	21 3 37 1	219 446	225 523
0.6 20.7KeV 0.185ū	250 334	257 407	265 483
0.73 17KeV 0.225ū	329 255	339 325	349 398
	1.5 8.3KeV 900μm	2 6.2KeV 360µm	3 4.1 KeV 100µm

wavelength cutoff [Å] energy cutoff [keV] thickness [µm]

Graphite filter setup

mirror setup

case of C-filter 360μm / 0.185° grazing angle 257 Watt absorbed

Temperature distribution [K°]

Mirror deformation [m] The coolant is water at 293K° and the flow is 300 l/h

SCW 2GeV, 320 mA, 1 mradH x 0.2mradV

Laboratory

in a second time: extend the range in the low energy direction

Sincrotrone Trieste S.c.p.A. Hard-X Ray Optics Laboratory in a second time: extend the range in the low energy direction or, if requested, open the energy window.....both with LN2 as coolant